



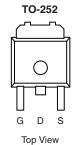
P-Channel 100-V (D-S) 175 °C MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)		
- 100	0.043 at V _{GS} = - 10 V	- 37	54 nC		
- 100	0.048 at V _{GS} = - 4.5 V	- 35	34 IIC		

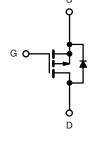
FEATURES

- TrenchFET® Power MOSFET
- Compliant to RoHS Directive 2002/95/EC





Drain Connected to Tab



Ordering Information: SUD50P10-43L-E3 (Lead (Pb)-free)

P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A =$	25 °C, unless other	wise noted		
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 100	V	
Gate-Source Voltage	V _{GS}	± 20		
	T _C = 25 °C		- 37.1 ^a	
Continuous Busin Comment (T., 175 cO)b	T _C = 125 °C	1 , [- 31 ^a	
Continuous Drain Current (T _J = 175 °C) ^b	T _A = 25 °C	l _D	- 9.2 ^{b, c}	
	T _A = 125 °C	1	- 7.7 ^{b, c}	
Pulsed Drain Current	I _{DM}	- 40	A	
Continuous Course Courset (Diede Condustion)	T _C = 25 °C	1	- 50 ^a	
Continuous Source Current (Diode Conduction)	T _A = 25 °C	l _S	- 6.9 ^{b, c}	
Avalanche Current	L = 0.1 mH	I _{AS}	- 35	
Single Pulse Avalanche Energy	L=0.1 IIII	E _{AS}	61	mJ
	T _C = 25 °C		136	
Maximum Dayyar Dissination	T _C = 70 °C	P_D	95	w
Maximum Power Dissipation	T _A = 25 °C	l LD	8.3 ^{b, c}	
	T _A = 70 °C		5.8 ^{b, c}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Junction-to-Ambient ^a	t ≤ 10 s	R_{thJA}	15	18	°C/W	
Junction-to-Ambient*	Steady State		40	50		
Junction-to-Case (Drain)		R_{thJC}	0.85	1.1		

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 40 $^{\circ}\text{C/W}.$



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				, ,			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, I}_{D} = -250 \mu\text{A}$	- 100			٧	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	J. 050 v.A		- 109		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		5.9			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
7 0 1 1/1 5 1 0 1		V _{DS} = - 100 V, V _{GS} = 0 V			- 1	<u> </u>	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 100 V, V _{GS} = 0 V, T _J = 55 °C			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = -10 \text{ V}$	- 40			Α	
		V _{GS} = - 10 V, I _D = - 9.2 A		0.036	0.043		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 7.7 A		0.040	0.048	Ω	
Forward Transconductance ^a	g _{fs}	V _{DS} = - 15 V, I _D = - 9.2 A		38		S	
Dynamic ^b							
Input Capacitance	C _{iss}			4600			
Output Capacitance	C _{oss}	$V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		230		рF	
Reverse Transfer Capacitance	C _{rss}			175			
	0	$V_{DS} = -50 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -9.2 \text{ A}$		106	160	nC	
Total Gate Charge	Qg			54	81		
Gate-Source Charge	Q_{gs}	$V_{DS} = -50 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -9.2 \text{ A}$		14		IIC	
Gate-Drain Charge	Q_{gd}			26			
Gate Resistance	R_g	f = 1 MHz		4		Ω	
Turn-On Delay Time	t _{d(on)}			15	25		
Rise Time	t _r	$V_{DD} = -50 \text{ V}, R_{L} = 6.5 \Omega$		20	30	no	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -7.7 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		110	165	ns	
Fall Time	t _f			100	150		
Turn-On Delay Time	t _{d(on)}			42	65		
Rise Time	t _r	$V_{DD} = -50 \text{ V}, R_{L} = 6.5 \Omega$		160	240		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -7.7 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		100	150	ns	
Fall Time	t _f			100	150		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 50	۸	
Pulse Diode Forward Current ^a	I _{SM}				- 40	A	
Body Diode Voltage	V _{SD}	I _S = - 7.7 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			60	90	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 7.7 A, dl/dt = 100 A/μs, T _{.l} = 25 °C		150	225	nC	
Reverse Recovery Fall Time	t _a	$I_{F} = -7.7 \text{ A}, \text{ al/al} = 100 \text{ A/}\mu\text{s}, I_{J} = 25 ^{\circ}\text{C}$		46			
Reverse Recovery Rise Time	t _b	-		14		ns	

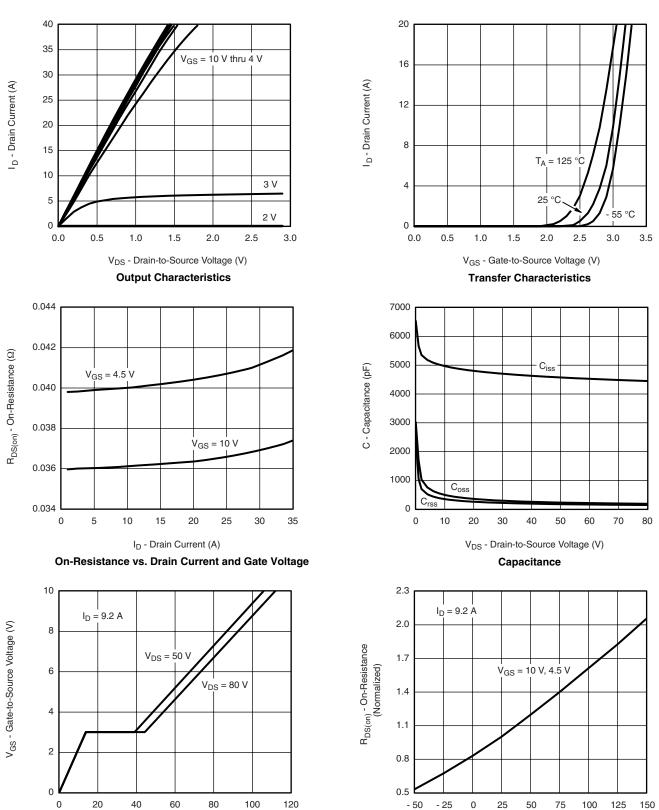
Notes:

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Qg - Total Gate Charge (nC)

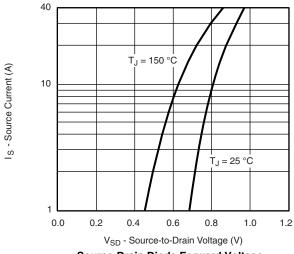
Gate Charge

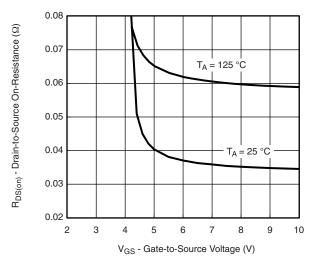
T_J - Junction Temperature (°C)

On-Resistance vs. Junction Temperature

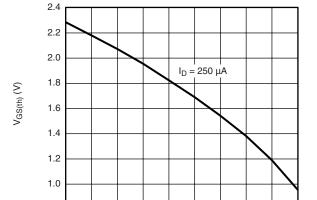
VISHAY

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

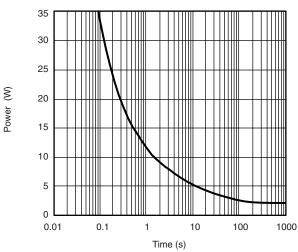




Source-Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage

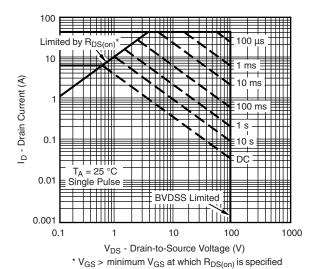


T_J - Temperature (°C)

Threshold Voltage

50 75 100 125 150

Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

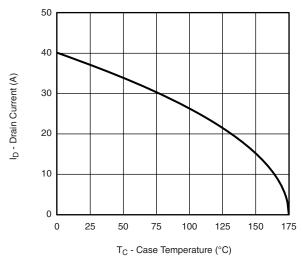
0.8

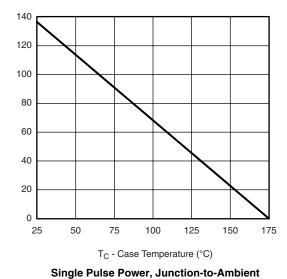
- 50 - 25

0

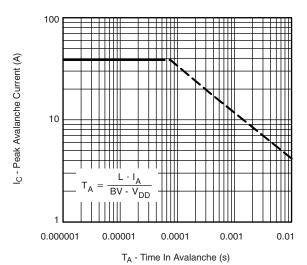


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





Current Derating*



Single Pulse Avalance Capability

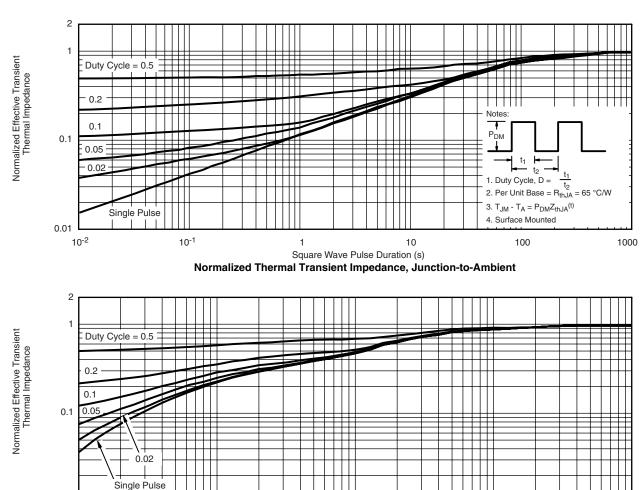
Power

^{*} The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

VISHAY.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

10-3



Normalized Thermal Transient Impedance, Junction-to-Case

10-2

Square Wave Pulse Duration (s)

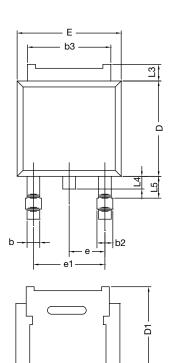
10-1

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?73444.

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TO-252AA Case Outline





	MILLIN	METERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	4.10	-	0.161	-	
E	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28 BSC		0.090 BSC		
e1	4.56	BSC	0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.01	1.52	0.040	0.060	
ECN: T16-0236-Rev. P, 16-May-16					

DWG: 5347

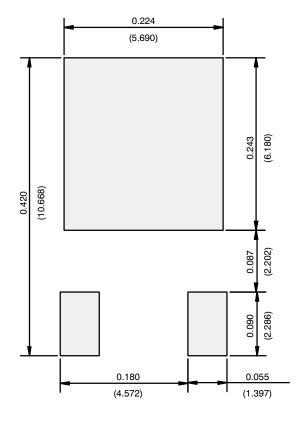
Notes

• Dimension L3 is for reference only.

Revision: 16-May-16 Document Number: 71197



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)

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APPLICATION NOTE



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